

Bis(*N,N*-dimethylthiocarbamoylthio)-acetic acid

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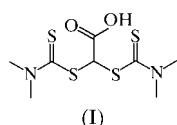
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Bis(*N,N*-dimethylthiocarbamoylthio)acetic acid, $[(\text{CH}_3)_2\text{N}-\text{C}(=\text{S})\text{S}]_2\text{CHC}(=\text{O})\text{OH}$ or $\text{C}_8\text{H}_{14}\text{N}_2\text{O}_2\text{S}_4$, exists as a centrosymmetric hydrogen-bonded dimer [$\text{O} \cdots \text{O}$ 2.661 (3) Å].

Comment

The thiocarbamoylthioacetic acids, $R_2\text{NC(S)SCH}_2\text{C(O)OH}$, are plant growth-regulating compounds (Fawcett *et al.*, 1956; van der Kerk *et al.*, 1995) that are readily synthesized by displacing the chloride of chloroacetic acid by the dithiocarbamate nucleophile (Nachmias, 1952). Their acid dissociation constants (Janssen, 1963) have been explained in terms of extensive mesomeric electron displacements of the thiocarbonyl group; the $R_2\text{NC(S)S}$ portion also exerts an appreciable electron-withdrawing effect (Janssen, 1962). The analogous $[R_2\text{NC(S)S}]_2\text{CHC(O)OH}$ acid is known only for the $R = \text{CH}_3$ homolog as other homologs cannot be synthesized by the reaction of the dithiocarbamate ion with dichloroacetic acid (Pluijgers, 1959). The title compound, (I), crystallizes as a centrosymmetric dimer that is held together by a short hydrogen bond [$\text{O} \cdots \text{O}$ 2.664 (3) Å]. Bond dimensions in the acid are similar to those found in the dicyclohexylammonium (Ng, 1996) and tetramethylammonium (Ng, 1997) salts. The tetramethylammonium salt crystallizes with a molecule of the acid, and the carboxylate and acid moieties are linked across a center of inversion by the acid H atom [$\text{O} \cdots \text{O}$ 2.486 (3) Å].



An examination of the bond dimensions found in $[(\text{CH}_3)_2\text{NC(S)S}]_2\text{CHC(O)OH}$ acid does not suggest any particularly abnormal values. The bond dimensions that are calculated by the *GAUSSIAN* suite (Frisch *et al.*, 1995) compare well with those found experimentally. Similar calculations were also performed on $[(\text{C}_2\text{H}_5)_2\text{N}-\text{C(S)S}]_2\text{CHC(O)OH}$ to ascertain why this and other homologs could not be isolated. The calculations, which used the same model chemistry (HF/3-21G), gave insignificant differences, other than for somewhat longer carbon–sulfur double-bonds, *i.e.* this acid should be thermodynamically stable (Table 2).

Experimental

The title acid was synthesized from dimethylamine, carbon disulfide and dichloroacetic acid (Nachmias, 1952; Pluijgers & van der Kerk, 1961), and crystals were obtained upon recrystallization of the compound from ethanol.

Crystal data

$\text{C}_8\text{H}_{14}\text{N}_2\text{O}_2\text{S}_4$	$Z = 2$
$M_r = 298.45$	$D_x = 1.422 \text{ Mg m}^{-3}$
Triclinic, $P\bar{1}$	Mo $K\alpha$ radiation
$a = 7.3275 (1) \text{ \AA}$	Cell parameters from 3176
$b = 7.6321 (2) \text{ \AA}$	reflections
$c = 12.6379 (4) \text{ \AA}$	$\theta = 2.80\text{--}28.28^\circ$
$\alpha = 95.809 (2)^\circ$	$\mu = 0.669 \text{ mm}^{-1}$
$\beta = 96.991 (1)^\circ$	$T = 293 (2) \text{ K}$
$\gamma = 92.244 (2)^\circ$	Block, faint tan
$V = 696.96 (3) \text{ \AA}^3$	$0.38 \times 0.30 \times 0.16 \text{ mm}$

Data collection

Siemens CCD area-detector	3349 independent reflections
diffractometer	2292 reflections with $I > 2\sigma(I)$
w scans	$R_{\text{int}} = 0.037$
Absorption correction: empirical (SADABS; Sheldrick, 1996)	$\theta_{\text{max}} = 28.28^\circ$
$T_{\text{min}} = 0.785$, $T_{\text{max}} = 0.900$	$h = -9 \rightarrow 9$
5032 measured reflections	$k = -10 \rightarrow 10$
	$l = -16 \rightarrow 9$

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.0705P)^2]$
$R[F^2 > 2\sigma(F^2)] = 0.053$	where $P = (F_o^2 + 2F_c^2)/3$
$wR(F^2) = 0.139$	$(\Delta/\sigma)_{\text{max}} = 0.001$
$S = 0.946$	$\Delta\rho_{\text{max}} = 0.38 \text{ e \AA}^{-3}$
3349 reflections	$\Delta\rho_{\text{min}} = -0.39 \text{ e \AA}^{-3}$
151 parameters	Extinction correction: <i>SHELXL97</i>
H-atom parameters constrained	Extinction coefficient: 0.030 (5)

Table 1
Hydrogen-bonding geometry (Å, °).

$D-\text{H} \cdots A$	$D-\text{H}$	$\text{H} \cdots A$	$D \cdots A$	$D-\text{H} \cdots A$
O1-H1 \cdots O2 ⁱ	0.82	1.84	2.661 (3)	178

Symmetry code: (i) $-x, -y, -z$.

Table 2

Bond distances (\AA) and angles ($^\circ$) derived from *ab initio* (HF/3-21G) calculations.

	(I)	HF/3-21G
S1—C3	1.790 (3)	1.856
S1—C2	1.812 (3)	1.873
S2—C3	1.655 (3)	1.713
S3—C6	1.783 (3)	1.841
S3—C2	1.799 (3)	1.856
S4—C6	1.661 (3)	1.720
O1—C1	1.313 (3)	1.312
O2—C1	1.214 (3)	1.214
N1—C3	1.332 (3)	1.332
N1—C5	1.463 (4)	1.461
N1—C4	1.467 (4)	1.469
N2—C6	1.326 (3)	1.327
N2—C8	1.462 (4)	1.462
N2—C7	1.465 (3)	1.462
C1—C2	1.531 (4)	1.529
C3—S1—C2	102.2 (1)	103.1
C6—S3—C2	102.4 (1)	101.5
C3—N1—C5	123.8 (2)	123.0
C3—N1—C4	119.7 (2)	118.8
C5—N1—C4	116.5 (2)	118.2
C6—N2—C8	123.4 (2)	122.4
C6—N2—C7	120.7 (2)	119.1
C8—N2—C7	115.8 (2)	118.5
O2—C1—O1	124.9 (3)	123.8
O2—C1—C2	123.0 (2)	126.8
O1—C1—C2	112.0 (2)	109.3
C1—C2—S3	113.9 (2)	113.0
C1—C2—S1	105.0 (2)	106.7
S3—C2—S1	106.4 (1)	107.1
N1—C3—S2	124.9 (2)	124.9
N1—C3—S1	111.4 (2)	112.5
S2—C3—S1	123.7 (2)	122.5
N2—C6—S4	125.6 (2)	124.8
N2—C6—S3	113.0 (2)	114.0
S4—C6—S3	121.4 (1)	121.2

Data collection: *SMART* (Siemens, 1996); cell refinement: *SAINT* (Siemens, 1996); data reduction: *SAINT*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); software used to prepare material for publication: *SHELXL97*.

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